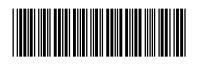
Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10510637	TAKAMINE ET AL.
Examiner	Art Unit
CHAU NGUYEN	2176

SEARCHED				
Class	Subclass	Date	Examiner	
715	200	03/30/2008	cn	
715	234-236	03/30/2008	cn	
715	243	03/30/2008	cn	
715	255	03/30/2008	cn	
715	273-274	03/30/2008	cn	
715	200	10/07/2008	cn	
715	234-236	10/07/2008	cn	
715	243	10/07/2008	cn	
715	255	10/07/2008	cn	
715	273-274	10/07/2008	cn	

SEARCH NOTES				
Search Notes	Date	Examiner		
Updated Search on East Reports	03/30/2008	cn		
Updated Search on East Reports	10/07/2008	cn		
Inventor Search for Double Patenting	10/07/2008	cn		
NPL Search on IEEE Explorer	10/07/2008	cn		
Updated Search on East Reports	03/27/2009	cn		

INTERFERENCE SEARCH				
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